 arcn N	

Application/Control No.	Applicant(s)/Patent Reexamination	under
10/722,293	YOSHIHARA ET A	L.
Examiner	Art Unit .	
Leonid Shapiro	2629	

SEARCHED				
Class	Subclass	Date	Examiner	
345	87		2-5.	
	90	_		
	97			
	205			
	696			
,				
			,	
		·		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
THE	SAME	07.23,07	45	
. AS I	BOUT		_	

(INCLUDING SEARCH	1	1
	DATE	EXMR
EAST	07-14	2.5
Inventors	09.14	4.5.